

N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY

V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A) ^{a, e}	Q_g (Typ.)
30	0.0149 at $V_{GS} = 10$ V	20	15nC
	0.019 at $V_{GS} = 4.5$ V	16	

FEATURES

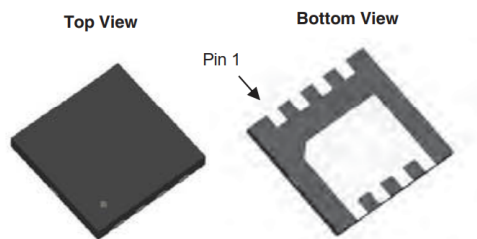
- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested

APPLICATIONS

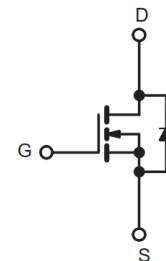
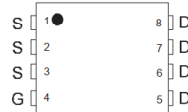
- Notebook PC Core
- VRM/POL


RoHS
 COMPLIANT

DFN 3x3 EP



Top View



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$, unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current ($T_J = 175^\circ\text{C}$)	$T_C = 25^\circ\text{C}$	I_D	20 ^{a, e}	A
	$T_C = 70^\circ\text{C}$		18 ^e	
	$T_A = 25^\circ\text{C}$		15 ^{b, c}	
	$T_A = 70^\circ\text{C}$		13 ^{b, c}	
Pulsed Drain Current		I_{DM}	60	mJ
Avalanche Current Pulse		I_{AS}	17	
Single Pulse Avalanche Energy		E_{AS}	16	
Continuous Source-Drain Diode Current	$T_C = 25^\circ\text{C}$	I_S	18 ^{a, e}	A
	$T_A = 25^\circ\text{C}$		13 ^{b, c}	
Maximum Power Dissipation	$T_C = 25^\circ\text{C}$	P_D	16	W
	$T_C = 70^\circ\text{C}$		7	
	$T_A = 25^\circ\text{C}$		4.5 ^{b, c}	
	$T_A = 70^\circ\text{C}$		2.6 ^{b, c}	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	- 55 to 175	$^\circ\text{C}$

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, d}	$t \leq 10$ s	R_{thJA}	31	44	$^\circ\text{C/W}$
Maximum Junction-to-Case	Steady State	R_{thJC}	3	4	

Notes:

 a. Based on $T_C = 25^\circ\text{C}$.

b. Surface mounted on 1" x 1" FR4 board.

 c. $t = 10$ s.

 d. Maximum under steady state conditions is 90°C/W .

e. Calculated based on maximum junction temperature.

SPECIFICATIONS ($T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)

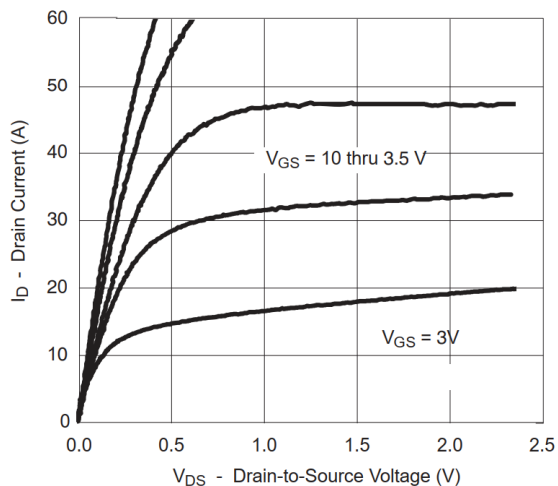
Parameter	Symbol	Test Conditions	Min .	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = 250 μA		35		mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J			- 5.5		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1		3	V
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 24 V, V _{GS} = 0 V			1	μA
		V _{DS} = 24 V, V _{GS} = 0 V, T _J = 55 °C			10	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	60			A
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 10 A		0.0149	0.017	Ω
		V _{GS} = 4.5 V, I _D = 8 A		0.019	0.022	
Forward Transconductance ^a	g _{fs}	V _{DS} = 24 V, I _D = 10 A		35		S
Dynamic ^b						
Input Capacitance	C _{iss}	V _{DS} = 24V, V _{GS} = 0 V, f = 1 MHz		655		pF
Output Capacitance	C _{oss}			422		
Reverse Transfer Capacitance	C _{rss}			109		
Total Gate Charge	Q _g	V _{DS} = 24 V, V _{GS} = 10 V, I _D = 10 A		14		nC
		V _{DS} = 24 V, V _{GS} = 4.5 V, I _D = 8 A		6.6		
Q _{gs}			4			
Q _{gd}			3			
Gate Resistance	R _g	f = 1 MHz		3		Ω
Turn-On Delay Time	t _{d(on)}	V _{DD} = 24 V, R _L = 1.8 Ω I _D ≅ 10 A, V _{GEN} = 10 V, R _g = 3 Ω		11		ns
Rise Time	t _r			9		
Turn-Off Delay Time	t _{d(off)}			25		
Fall Time	t _f			12		
Turn-On Delay Time	t _{d(on)}	V _{DD} = 24 V, R _L = 1.8 Ω I _D ≅ 8 A, V _{GEN} = 4.5 V, R _g = 3 Ω		20		
Rise Time	t _r			17		
Turn-Off Delay Time	t _{d(off)}			50		
Fall Time	t _f			18		
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			18	A
Pulse Diode Forward Current ^a	I _{SM}				54	
Body Diode Voltage	V _{SD}	I _S = 10 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}	I _F = 10 A, di/dt = 100 A/μs, T _J = 25 °C		10		ns
Body Diode Reverse Recovery Charge	Q _{rr}			15		nC
Reverse Recovery Fall Time	t _a			20		ns
Reverse Recovery Rise Time	t _b			22		

Notes:

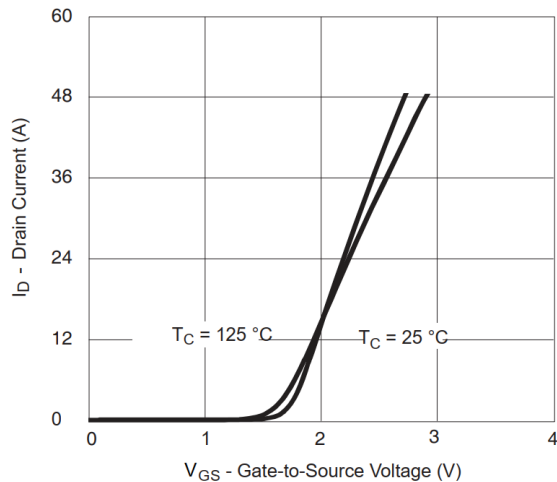
- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
 b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

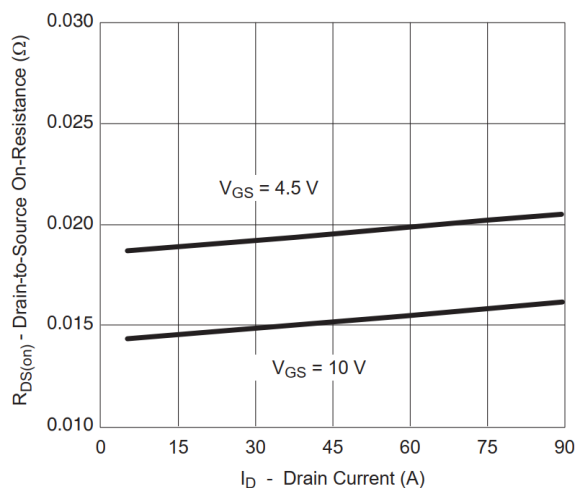
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



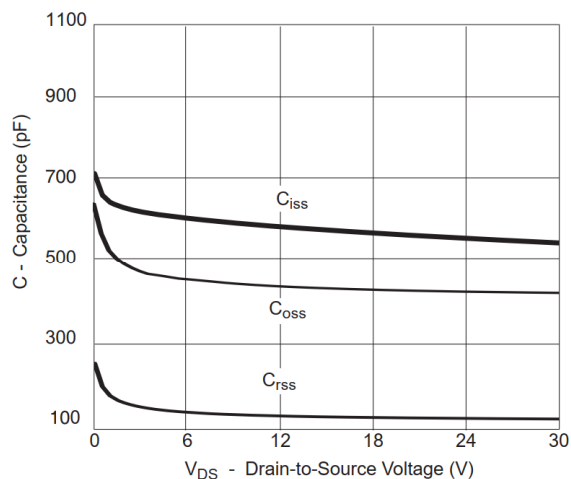
Output Characteristics



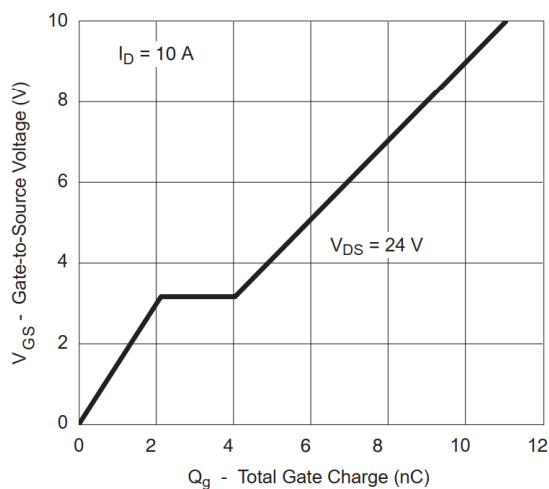
Transfer Characteristics



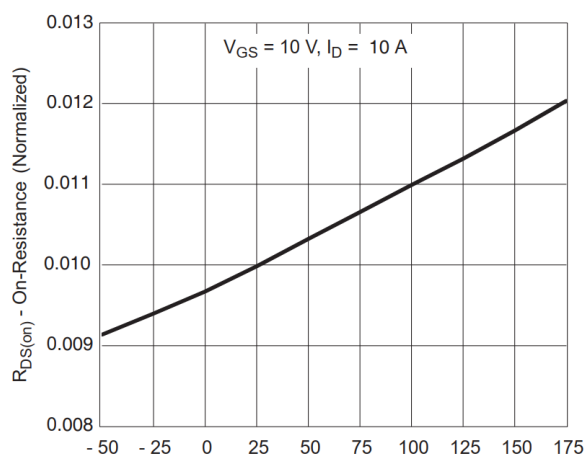
$R_{DS(on)}$ vs. Drain Current



Capacitance

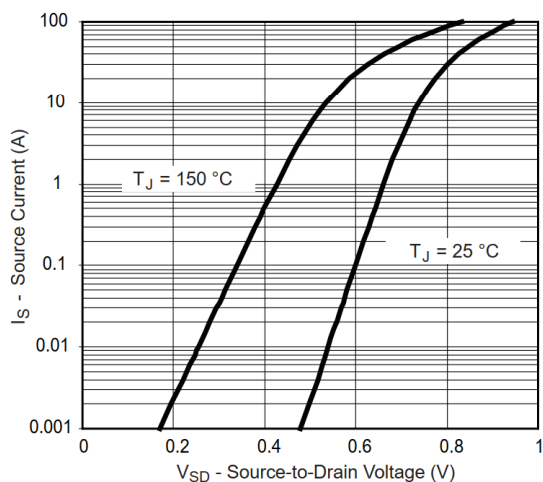


Gate Charge

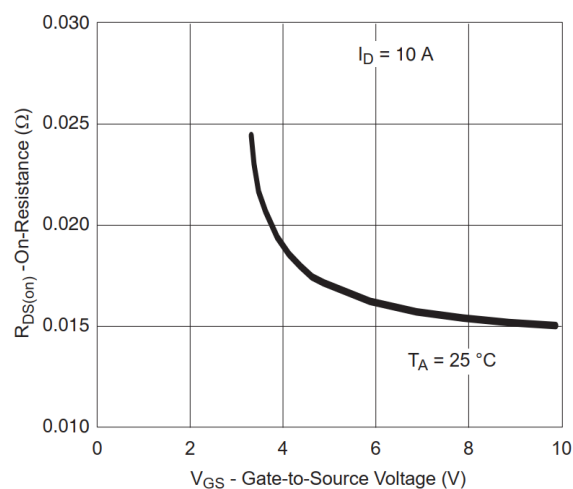


On-Resistance vs. Junction Temperature

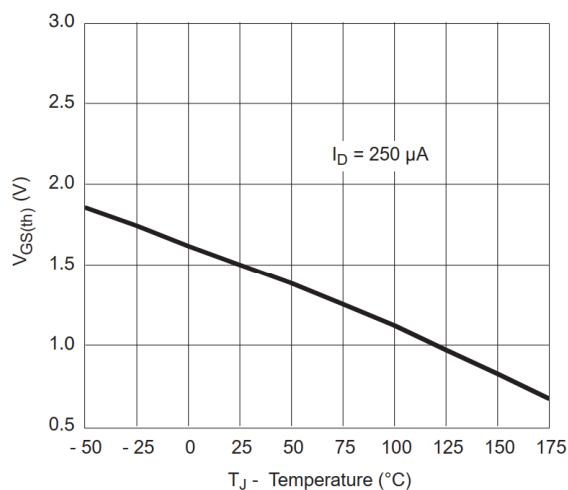
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



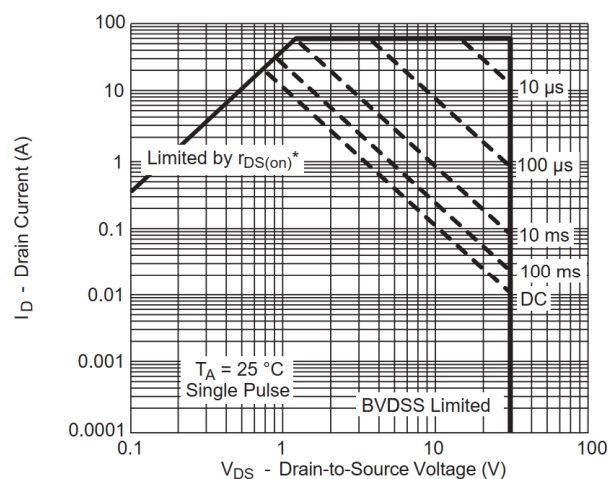
Forward Diode Voltage vs. Temperature



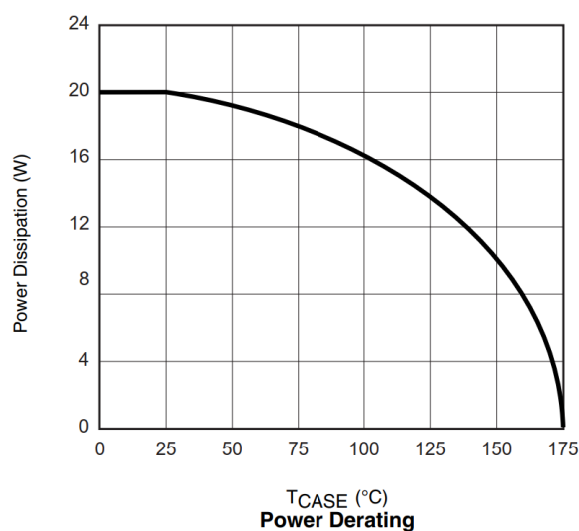
$R_{DS(on)}$ vs. V_{GS} vs. Temperature



Threshold Voltage

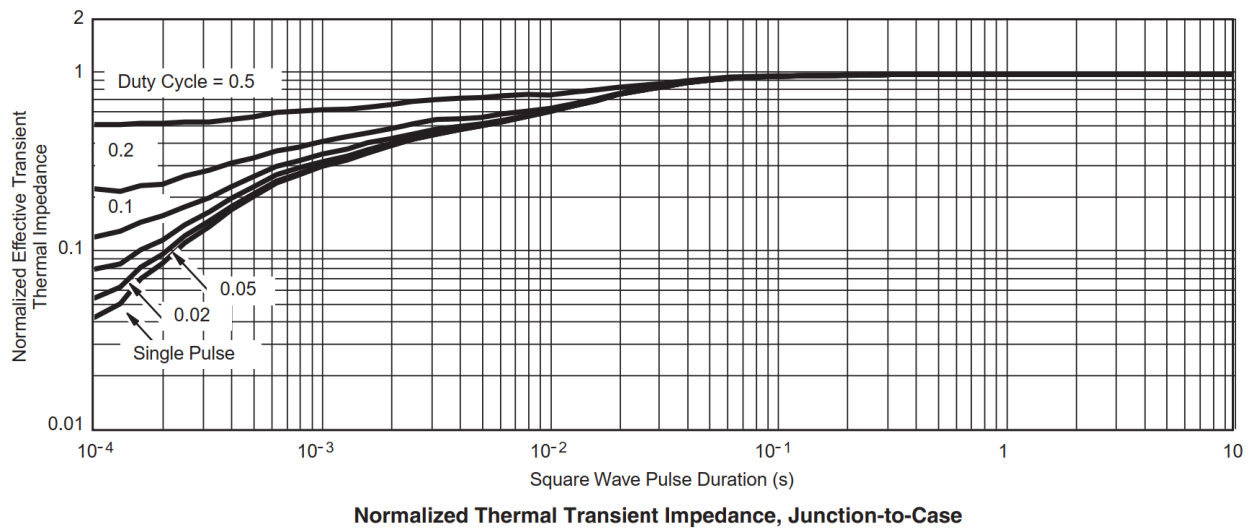


Safe Operating Area, Junction-to-Ambient

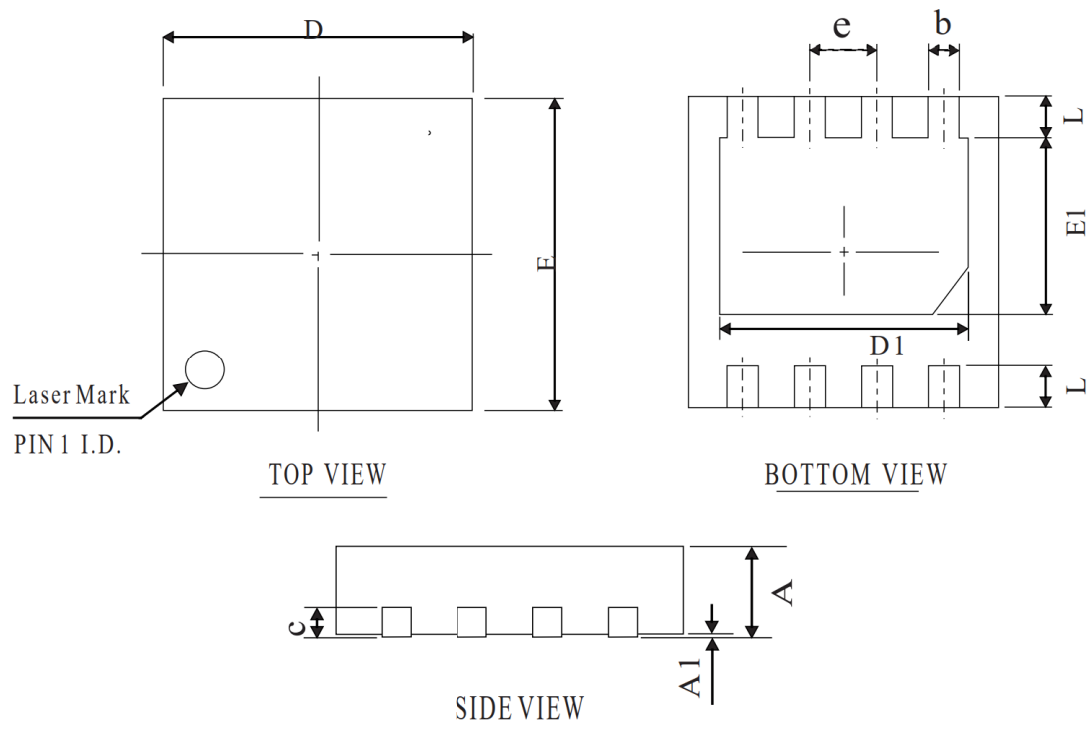


Power Derating

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



DFN3*3-8L PACKAGE OUTLINE



COMMON DIMENSIONS
(UNITS OF MEASURE=mm)

SYMBOL	MIN	NOM	MAX
A	0.60	0.75	0.90
A1	0.00	0.02	0.08
b	0.20	0.30	0.45
D	2.85	3.00	3.15
E	2.85	3.00	3.15
D1	2.10	2.40	2.70
E1	1.50	1.70	2.00
L	0.20	0.40	0.60
c	0.203 REF		
e	0.65 BSC		

OTHER DIMENSIONS

A	0.50	0.55	0.60
A	0.40	0.45	0.50

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